

# EMC TEST REPORT

<b>Project No.</b>	LBE20125852	<b>Issue No.</b>	0
<b>Applicant</b>	<b>Name of organization</b>	Samsung Electronics Co., Ltd.	
	<b>Address</b>	(Maetan-dong) 129, Samsung-ro, Yeongtong-gu, Suwon-si, Gyeonggi-do, 443-742, Republic of Korea	
	<b>Date of application</b>	December 19, 2012	
<b>EUT</b>	<b>Type of device</b>	<input checked="" type="checkbox"/> Class B personal computers and peripherals <input type="checkbox"/> All other devices	
	<b>Equipment authorization</b>	<input type="checkbox"/> Declaration of Conformity <input checked="" type="checkbox"/> Certification <input type="checkbox"/> Verification	
	<b>FCC ID</b>	A3LSGHT599	
	<b>Kind of product</b>	Mobile Phone	
	<b>Model No.</b>	SGH-T599	
	<b>Variant Model No.</b>	Refer to clause 4.6	
	<b>Manufacturer</b>	SAMSUNG ELECTRONICS CO., LTD. 94-1, Imsu-dong, Gumi-si, Gyengsangbuk-do, 730-722, Republic of Korea	
<b>Applied Standards</b>	FCC Part 15, Subpart B, Class B / ANSI C63.4-2003		
<b>Test Period</b>	December 20, 2012 ~ December 21, 2012		
<b>Issue date</b>	December 27, 2012		

**Test result : Complied**

The equipment under test has found to be compliant with the applied standards.  
 (Refer to the attached test result for more detail.)

**Tested by** : Jong-Sup Jeong



**Reviewed by** : Tae-Young Jang



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# 1. Report Information

## 1.1 Revision history

No.	Revised detailed information
Issue 0	- LBE20125852 (SAMSUNG)

# 2. Summary of test results

## 1.1 Emission

The EUT has been tested according to the following specifications:

Applied	Test type	Applied standard	Result
<input checked="" type="checkbox"/>	Conducted Disturbance (Mains port)	FCC Part 15 Subpart B / ANSI C63.4-2003 (Class B)	Complied
<input checked="" type="checkbox"/>	Radiated Disturbance		Complied

# 3. General Information

## 3.1 Test facility

The CS & Environment center is located on Samsung Electronics Co., Ltd. at (Maetan-dong) 129, Samsung-ro, Yeongtong-gu, Suwon-si, Gyeonggi-do, Republic of Korea.

All testing are performed in Semi-anechoic chambers conforming to the site attenuation characteristics defined by ANSI C63.4, CISPR 22, 16-1 and 16-2. and Shielded rooms.

The CS & Environment center is operated as testing laboratory in accordance with the requirements of ISO/IEC 17025:2005.

## 4. Test Setup configuration

### 4.1 Test Peripherals

The cables used for these peripherals are either permanently attached by the peripheral manufacturer or coupled with an assigned cable as defined below.

The following is a listing of the EUT and peripherals utilized during the performance of EMC test:

Mark	Description	Model No.	Serial No.	Manufacturer / Trademark	FCC ID / DoC
A	Mobile Phone	SGH-T599	R31C815HCAL	SAMSUNG	A3LSGHT599
B	Battery	EB425161LA	AAbCA31KS/2-B	SAMSUNG	-
C	Headset	EHS61ASFWE	-	SAMSUNG	-
D	Data Cable	ECC1DU4BBE	-	SAMSUNG	-
E	microSD Card	16GB	-	SANDISK	-
F	Travel Adapter	ETA0U10JBE	DK2BB19TS/7-E	SAMSUNG	-
G	Desk-Top Computer	HP Compaq dx2200 Microtower	CNG7060LW0	HP	DoC
H	LCD Monitor	GH15LS	N719HVELA11890L	SAMSUNG	DoC
I	Mouse	N3+Optical	K034729902	HP	DoC
J	Keyboard	SDM8500P	8M000131	SAMSUNG	DoC
K	Gigabit Switch 8	3CGSU08	AB/9XRQAC0024825	3COM	DoC
L	Power Supply	PW150	KA1203N03	AULT	DoC

### 4.2 EUT operating mode

To achieve compliance applied standard specification, the following mode(s) were made during compliance testing:

<b>Operating Mode 1</b>	USB Mode (Data Communication)
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### 4.3 Details of Sampling

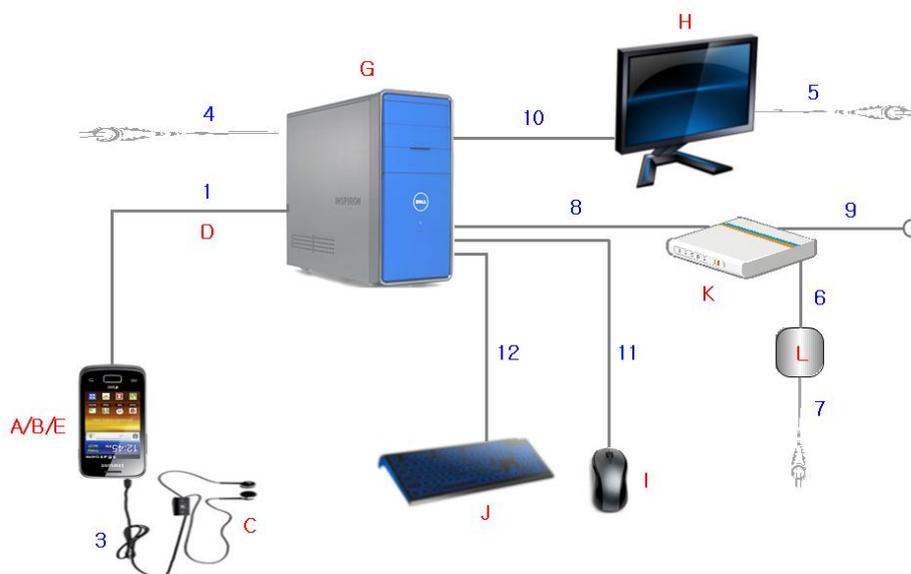
Customer selected, single unit.

## 4.4 Used cable description

The EUT is configured, installed, arranged and operated in a manner consistent with typical applications. Interface cables/loads/devices are connected to at least one of each type of interface port of the EUT, and where practical, each cable shall be terminated in a device typical of actual usage. The type(s) of interconnecting cables to be used and the interface port (of the EUT) to which these were connected:

No.	Connected cable	Length [m]	Shielded [Y/N]	Note
1	Data Cable	1.0	Yes	From EUT to Desk-Top Computer
2	Travel Adapter	1.5	No	From EUT to Travel Adapter
3	Headset	1.6	No	For EUT
4	Power	1.8	No	For Desk-Top Computer
5	Power	1.8	No	For LCD Monitor
6	Power	1.8	No	From Gigabit Switch 8 to Power Supply
7	Power	1.8	No	For Power Supply
8	LAN	1.5	No	From Desk-Top Computer to Gigabit Switch 8
9	LAN	1.5	No	From Gigabit Switch 8 to Local Area Network
10	RGB	1.8	Yes	From Desk-Top Computer to LCD Monitor
11	PS/2	1.8	Yes	From Desk-Top Computer to Mouse
12	PS/2	1.8	Yes	From Desk-Top Computer to Keyboard

## 4.5 Test arrangement



## 4.6 EUT Description

4.6.1 The following features describe EUT represented by this report:

Item	Specification	
Frequency Range	GSM850	TX : 824.2 ~ 848.8 MHz RX : 869.2 ~ 893.8 MHz
	GSM1900	TX : 1 850.2 ~ 1 909.8 MHz RX : 1 930.2 ~ 1 989.8 MHz
	WCDMA FDD2	TX : 1 850 ~ 1 910 MHz RX : 1 930 ~ 1 990 MHz
	WCDMA FDD5	TX : 824 ~ 849 MHz RX : 869 ~ 894 MHz
Operating Temperature (°C)	-20 ~ +60	
Operating Humidity (%)	0 ~ 95	

4.6.2 The variant models

- None

## 4.7 Clock Frequencies

Kind of Clocks	Frequency [ MHz ]	Kind of Clocks	Frequency [ MHz ]
CPU	1 000	USB 2.0	24

## 4.8 Test configuration and condition

- The EUT exercise program which is the samsung standardized emission test program for windows was used during all EMC measurements were tested. This program was contained on the PC hard disk drive. Once loaded, the program sequentially exercises each system component in turn.
- The EUT was exercised during the testing by data read and write cycles repeated with internal storage devices. At the end of the test, the copied back data was compared with original.
- The EUT was connected to the PC by using USB data cable to charge.
- The system was configured for testing in a typical fashion that a customer would normally use, and was tested while in an automated non-attendant mode.

Power source for the EUT operating was supplied by CVCF made by the Pacific Power Source Corp.

- Test Voltage : AC 120 V, 60 Hz

## 4.9 Measurement uncertainty

Where relevant, the following measurement uncertainty levels have been estimated for tests performed on the apparatus: (According to CISPR 16-4 and UKAS Lab 34.)

### 4.9.1 Emission

Test type		Measurement uncertainty (C.L. 95 %, k = 2)
Conducted disturbance	AC Mains	$\pm 3.24$ dB
Radiated Disturbance (30 MHz ~ 1 GHz)	Horizontal	$\pm 4.59$ dB
	Vertical	$\pm 4.75$ dB
Radiated Disturbance (1 GHz ~ 6 GHz)	Horizontal	$\pm 4.18$ dB
	Vertical	$\pm 4.15$ dB

## 5. Results of individual test

### 5.1 Conducted disturbance

Both conducted lines are measured in Quasi-Peak and Average mode, including the worst-case data points for each tested configuration. The EUT measured in accordance with the methods described in standards.

#### Limits for conducted disturbance at the mains ports of Class B ITE

Frequency range Limits [ MHz ]	Resolution Bandwidth [ kHz ]	Limits [ dB(μV) ]	
		Quasi-peak	Average
0,15 to 0,50	9	66 to 56	56 to 46
0,50 to 5	9	56	46
5 to 30	9	60	50

NOTE 1 The lower limit shall apply at the transition frequency.  
NOTE 2 The limit decreases linearly with the logarithm of the frequency in the range 0.15 MHz to 0.50 MHz.

#### 5.1.1 Test instrumentation

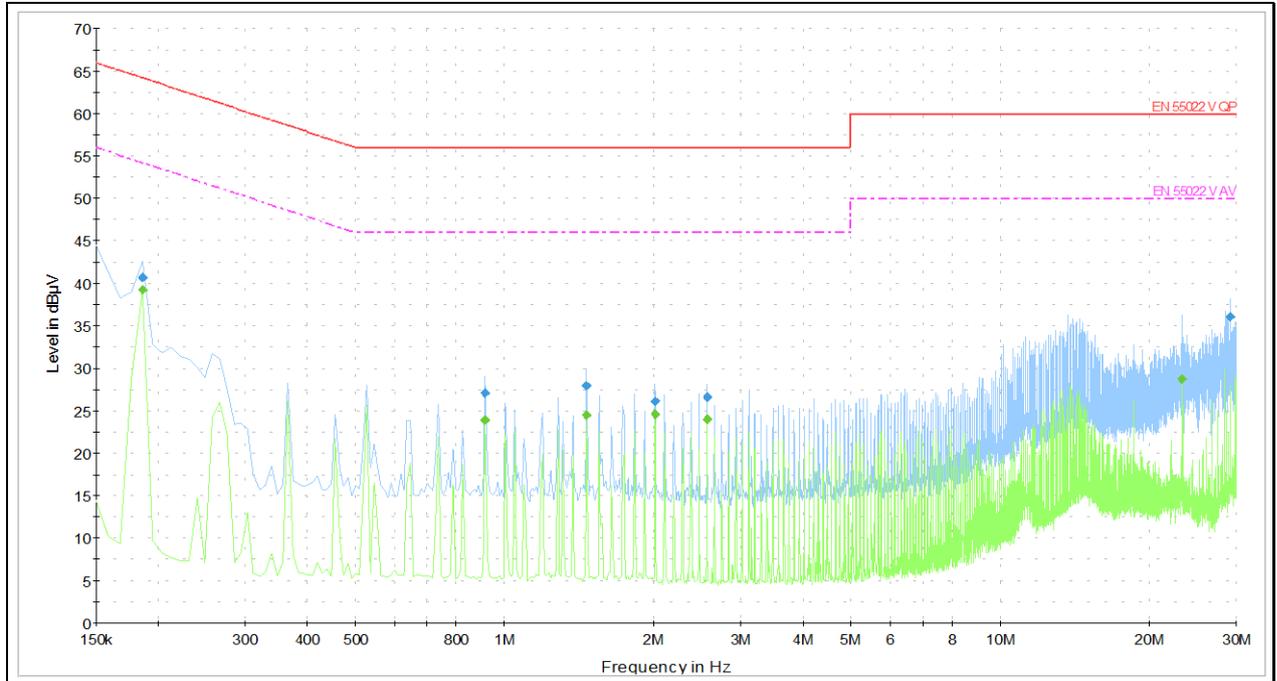
EMC No.	Test Instrument	Model name	Manufacturer	Serial No.	Calibration	
					Date	Interval (Month)
E3I-049	LISN	ESH3-Z5	R&S	100260	2012-01-04	12
E3I-238	Universal Radio Communicator	CMU200	R&S	120045-IQ	2012-08-22	12
E3I-259	LISN	ENV216	R&S	101369	2012-12-07	12
E3I-266	EMI Test Receiver	ESCI3	R&S	100086	2012-11-27	12

#### 5.1.2 Temperature and humidity condition

Test date	2012-12-21	Test engineer	Jong-Sup Jeong
Climate condition	Ambient temperature	23.5 °C	Limit (15.0 to 35.0) °C
	Relative humidity	37.0 % R.H.	Limit (25.0 to 75.0) % R.H.
	Atmospheric pressure	101.1 kPa	Limit (86.0 to 106.0) kPa
Test place	Shield Room (SR8)		

### 5.1.3 Test results

#### □ Operating Mode 1: AC Mains



Note 1) Two graphs measured for both Live(L1) and Neutral(N) of the LISN are combined into one graph.

Quasi-peak final measurement results table:

Frequency (MHz)	Level (dBµV)	Corr. (dB)	Limit (dBµV)	Margin (dB)	Line
0.186	40.7	10.1	64.2	23.5	L1
0.915	27.1	9.9	56.0	28.9	L1
1.464	28.0	9.8	56.0	28.0	L1
2.013	26.1	9.7	56.0	29.9	L1
2.562	26.6	9.7	56.0	29.4	L1
29.130	36.0	9.9	60.0	24.0	L1

Average final measurement results table:

Frequency (MHz)	Level (dBµV)	Corr. (dB)	Limit (dBµV)	Margin (dB)	Line
0.186	39.3	10.1	54.2	14.9	L1
0.915	23.9	9.9	46.0	22.1	L1
1.464	24.5	9.8	46.0	21.5	L1
2.013	24.6	9.7	46.0	21.4	L1
2.562	24.0	9.7	46.0	22.0	L1
23.298	28.7	9.9	50.0	21.3	L1

Note 2) Level (QP and/or AV) = Meter Reading (QP and/or AV) + Corr. (LISN Insertion Loss + Cable Loss)  
 Margin (QP and/or AV) = Limit – Level (QP and/or AV)  
 QP = Quasi-Peak, AV = Average

## 5.2 Radiated disturbance

The following data lists the significant emission frequencies, measured levels, correction factors (for antenna and cables), orientation of table, polarization and height of antenna, the corrected reading, the limit, and the amount of margin.

Peak measurements were made over the changeable frequency range 30 MHz to 1 GHz at a measurement distance of 10 m for the following antenna and turntable arrangements:

Antenna Height [ cm ]	Antenna Polarisation	Resolution Bandwidth [ kHz ]	Video Bandwidth [ kHz ]	Turntable position [ degrees ]
100 ~ 400	Horizontal, Vertical	120	300	Continuous

Measurements within 6 dB of the limit were then maximized by adjusting turntable position. Final measurements were made using quasi-peak detectors.

Peak/Average measurements were made over the changeable frequency range 1 GHz to 40 GHz or 5th harmonics of the highest frequency in accordance with internal maximum operating frequency at a measurement distance of 3 m for the following antenna and turntable arrangements:

Antenna Height [ cm ]	Antenna Polarisation	Resolution Bandwidth [ MHz ]	Video Bandwidth [ MHz ]	Turntable position [ degrees ]
100 ~ 400	Horizontal, Vertical	1 (PK / AV)	3 (PK) 10 Hz (AV)	Continuous

Measurements within 6 dB of the limit were then maximized by adjusting turntable position. Final measurements were made using peak and average detectors.

### Limits for radiated disturbance of Class B ITE at a measuring distance of 3 m and 10 m

Frequency range Limits [ MHz ]	Field Strength		
	3 m [ $\mu\text{V/m}$ ]	3 m [ dB( $\mu\text{V/m}$ ) ]	10 m [ dB( $\mu\text{V/m}$ ) ]
30 to 88	100	40.0	29.5
88 to 216	150	43.5	33.0
216 to 960	200	46.0	35.5
Above 960	500	54.0	43.5

Results checked manually; and points close to the limit line were re-measured.

## 5.2.1 Test instrumentation

EMC No.	Test Instrument	Model name	Manufacturer	Serial No.	Calibration	
					Date	Interval (Month)
E3I-003	BILOG Antenna	CBL6112B	Schaffner	2805	2012-04-19	24
E3I-045	Universal Radio Communicator	CMU200	R&S	100612	2012-02-06	12
E3I-170	Double-Ridged Waveguide Horn Antenna	HF906	R&S	100028	2012-08-13	24
E3I-190	BILOG Antenna	CBL6112B	Schaffner	2804	2011-06-22	24
E3I-213	Preamplifier	317	Sonoma	282424	2012-11-14	12
E3I-214	Preamplifier	317	Sonoma	282425	2012-11-14	12
E3I-228	EMI Test Receiver	ESU-08	R&S	100084	2012-10-18	12
E3I-233	EMI Test Receiver	ESU-26	R&S	100364	2012-10-26	12

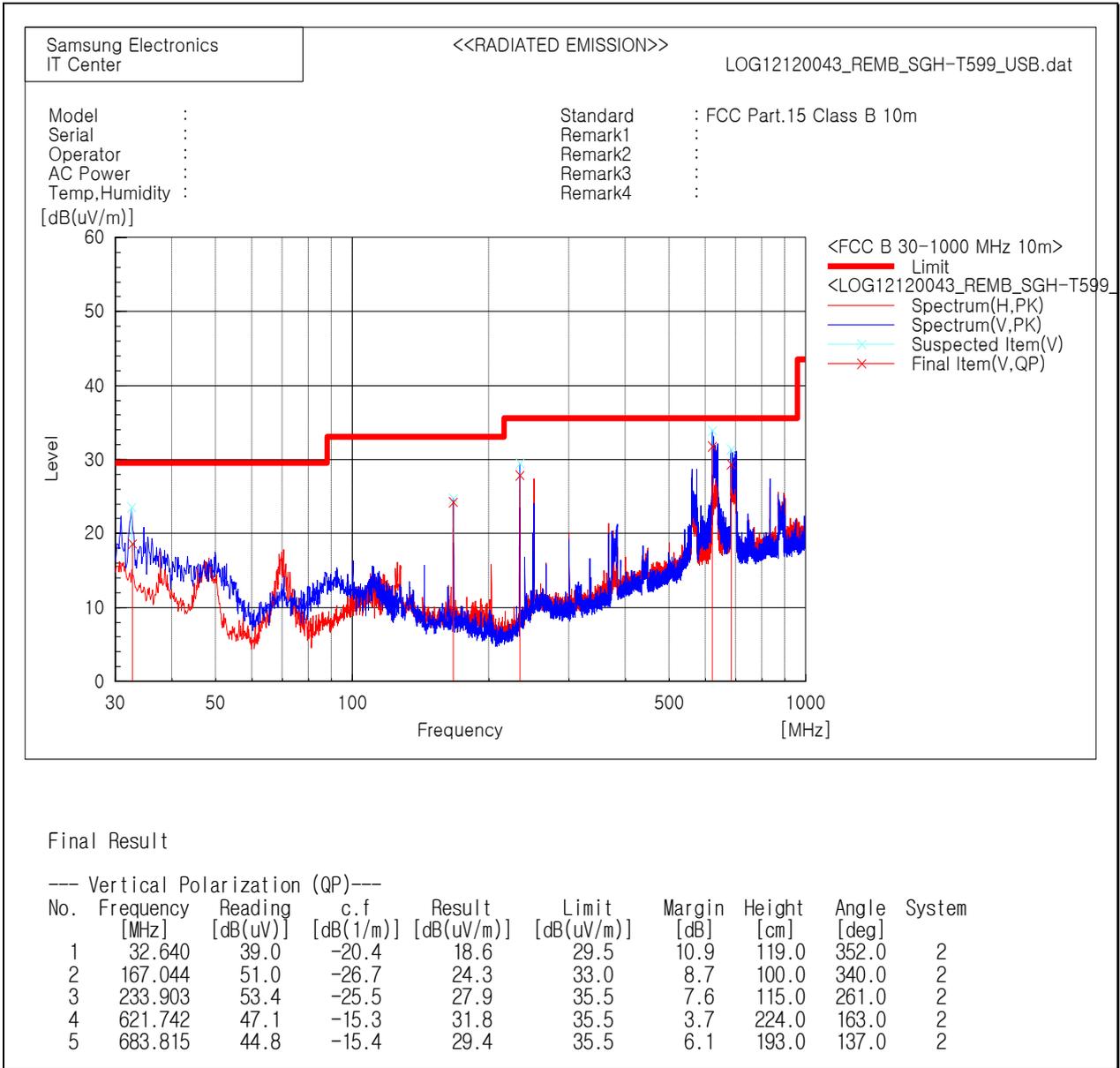
## 5.2.2 Temperature and humidity condition

<b>Test date</b>	2012-12-20	<b>Test engineer</b>	Jong-Sup Jeong
<b>Climate condition</b>	Ambient temperature	23.5 °C	Limit (15.0 to 35.0) °C
	Relative humidity	39.0 % R.H.	Limit (25.0 to 75.0) % R.H.
	Atmospheric pressure	101.5 kPa	Limit (86.0 to 106.0) kPa
<b>Test place</b>	Semi-Anechoic Chamber (SAC4)		

### 5.2.3 Test results

Operating Mode 1

- Frequency range: 30 ~ 1 000 MHz

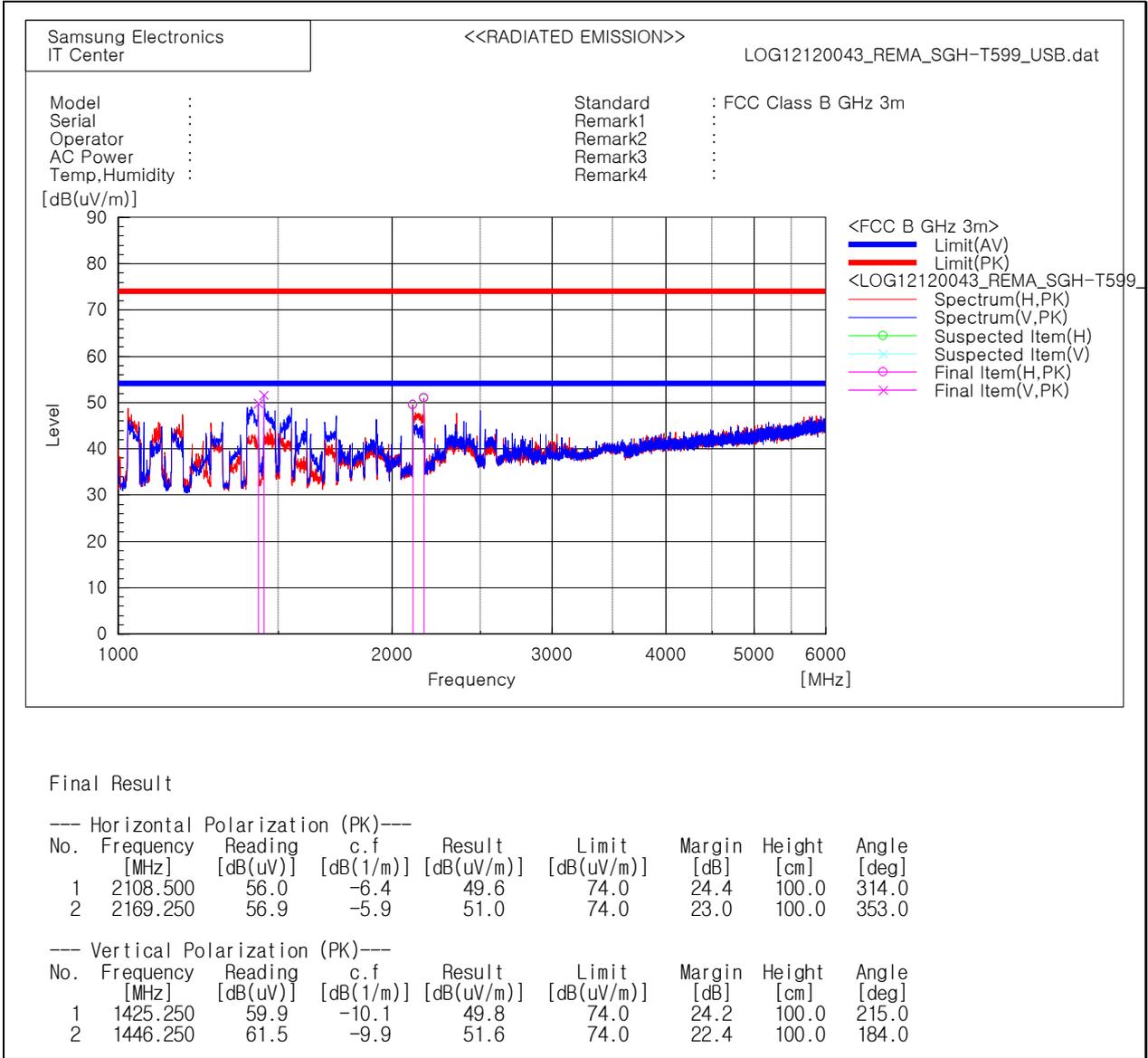


Note) Receiving antenna polarization : Horizontal, Vertical  
 Test Distance : 10 m, Antenna Height : 1 to 4 meters  
 Level (QP) = Reading (QP) + c.f (Antenna Factor + Cable Loss - Amp. Gain)  
 Margin (QP) = Limit - Level (QP)  
 QP = Quasi-Peak

### 5.2.3 Test results

Operating Mode 1

- Frequency range: 1 000 ~ 6 000 MHz



Note 1) Radiated emissions that do not exceed average limit were not tested with average detector mode.

Note 2) Receiving antenna polarization : Horizontal, Vertical  
 Test Distance : 3 m, Antenna Height : 1 to 4 meters  
 Level (PK and/or AV) = Reading (PK and/or AV) + Corr. (Antenna Factor + Cable Loss - Amp. Gain)  
 Margin (PK and/or AV) = Limit – Level (PK and/or AV)  
 PK = Peak, AV = Average